



## 16-BIT, DUAL CHANNEL, ULTRA-LOW GLITCH, VOLTAGE OUTPUT DIGITAL-TO-ANALOG CONVERTER

### FEATURES

- **Relative Accuracy: 4LSB**
- **Glitch Energy: 0.15nV-s**
- **MicroPower Operation:**  
155 $\mu$ A per Channel at 2.7V
- **Power-On Reset to Zero-Scale**
- **Power Supply: 2.7V to 5.5V**
- **16-Bit Monotonic Over Temperature**
- **Settling Time: 10 $\mu$ s to  $\pm$ 0.003% FSR**
- **Ultra-Low AC Crosstalk: -100dB Typ**
- **Low-Power Serial Interface with Schmitt-Triggered Inputs**
- **On-Chip Output Buffer Amplifier with Rail-to-Rail Operation**
- **Double-Buffered Input Architecture**
- **Simultaneous or Sequential Output Update and Power-down**
- **Available in a Tiny MSOP-8 Package**

### APPLICATIONS

- **Portable Instrumentation**
- **Closed-Loop Servo Control**
- **Process Control**
- **Data Acquisition Systems**
- **Programmable Attenuation**
- **PC Peripherals**

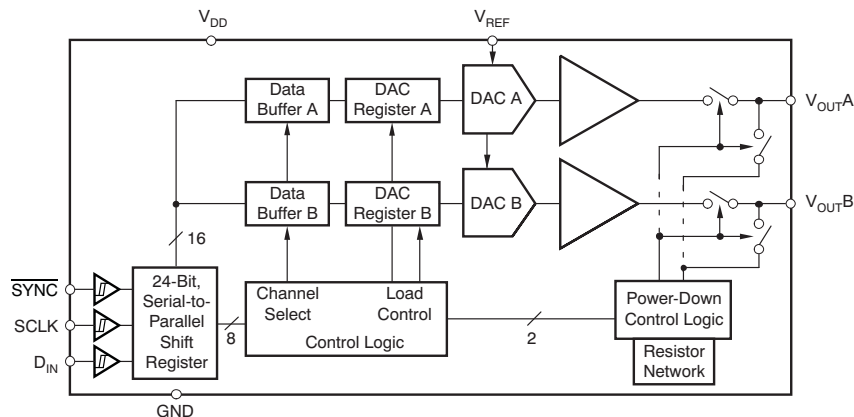
### DESCRIPTION

The DAC8552 is a 16-bit, dual channel, voltage output digital-to-analog converter (DAC) offering low power operation and a flexible serial host interface. Each on-chip precision output amplifier allows rail-to-rail output swing to be achieved over the supply range of 2.7V to 5.5V. The device supports a standard 3-wire serial interface capable of operating with input data clock frequencies up to 30MHz for  $V_{DD} = 5V$ .

The DAC8552 requires an external reference voltage to set the output range of each DAC channel. Also incorporated into the device is a power-on reset circuit which ensures that the DAC outputs power up at zero-scale and remain there until a valid write takes place. The DAC8552 provides a flexible power-down feature, accessed over the serial interface, that reduces the current consumption of the device to 700nA at 5V.

The low-power consumption of this device in normal operation makes it ideally suited for portable, battery-operated equipment and other low-power applications. The power consumption is 0.5mW per channel at 2.7V, reducing to 1 $\mu$ W in power-down mode.

The DAC8552 is available in a MSOP-8 package with a specified operating temperature range of -40°C to +105°C.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### PACKAGING/ORDERING INFORMATION<sup>(1)</sup>

PRODUCT	MAXIMUM RELATIVE ACCURACY (LSB)	MAXIMUM DIFFERENTIAL NONLINEARITY (LSB)	PACKAGE LEAD	PACKAGE DESIGNATOR	SPECIFICATION TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
DAC8552	±12	±1	MSOP-8	DGK	–40°C to +105°C	D82	DAC8552IDGKT	Tape and Reel, 250
							DAC8552IDGKR	Tape and Reel, 2500

(1) For the most current package and ordering information, see the Package Option Addendum at the of this document, or see the TI website at [www.ti.com](http://www.ti.com).

### ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted).<sup>(1)</sup>

		UNIT
V <sub>DD</sub> to GND		–0.3V to 6V
Digital input voltage to GND		–0.3V to V <sub>DD</sub> + 0.3V
V <sub>OUTA</sub> or V <sub>OUTB</sub> to GND		–0.3V to V <sub>DD</sub> + 0.3V
Operating temperature range		–40°C to +105°C
Storage temperature range		–65°C to +150°C
Junction temperature (T <sub>J</sub> max)		+150°C
Power dissipation		(T <sub>J</sub> max – T <sub>A</sub> )/θ <sub>JA</sub>
Thermal impedance	θ <sub>JA</sub>	206°C/W
	θ <sub>JC</sub>	44°C/W

(1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.

### ELECTRICAL CHARACTERISTICS

V<sub>DD</sub> = 2.7V to 5.5V, all specifications –40°C to +105°C (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>STATIC PERFORMANCE<sup>(1)</sup></b>					
Resolution		16			Bits
Relative accuracy	Measured by line passing through codes 513 and 64741		±4	±12	LSB
Differential nonlinearity	16-bit monotonic		±0.35	±1	LSB
Zero code error	Measured by line passing through codes 485 and 64741		±2.5	±12	mV
Zero code error drift			±5		µV/°C
Full-scale error	Measured by line passing through codes 485 and 64741		±0.1	±0.5	% of FSR
Gain error	Measured by line passing through codes 485 and 64741		±0.08	±0.2	% of FSR
Gain temperature coefficient			±1		ppm of FSR/°C
PSRR	Output unloaded		0.75		mV/V

(1) Linearity calculated using a reduced code range of 513 to 64741. Output unloaded.

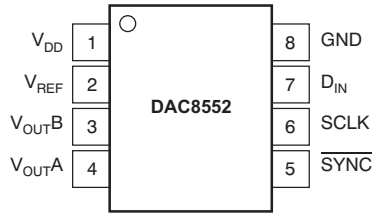
**ELECTRICAL CHARACTERISTICS (continued)**
 $V_{DD} = 2.7V$  to  $5.5V$ , all specifications  $-40^{\circ}C$  to  $+105^{\circ}C$  (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OUTPUT CHARACTERISTICS (2)</b>					
Output voltage range		0		$V_{REF}$	V
Output voltage settling time	$T_0 \pm 0.003\%$ FSR 0200h to FD00h, $R_L = 2k\Omega$ ; $0pF < C_L < 200pF$		8	10	$\mu s$
	$R_L = 2k\Omega$ ; $C_L = 500pF$		12		
Slew rate			1.8		V/ $\mu s$
Capacitive load stability	$R_L = \infty$		470		pF
	$R_L = 2k\Omega$		1000		
Code change glitch impulse	1LSB change around major carry		0.15		nV-s
Digital feedthrough	50k $\Omega$ series resistance on digital lines		0.15		nV-s
DC crosstalk	Full-scale swing on adjacent channel. $V_{DD} = 5V$ , $V_{REF} = 4.096V$		0.25		LSB
AC crosstalk	1kHz sine wave		-100		dB
DC output impedance	At mid-point input		1		$\Omega$
Short circuit current	$V_{DD} = 5V$		50		mA
	$V_{DD} = 3V$		20		
Power-up time	Coming out of power-down mode, $V_{DD} = 5V$		2.5		$\mu s$
	Coming out of power-down mode, $V_{DD} = 3V$		5		$\mu s$
<b>AC PERFORMANCE</b>					
SNR	BW = 20kHz, $V_{DD} = 5V$ , $f_{OUT} = 1kHz$ , 1st 19 harmonics removed for SNR calculation		95		dB
THD			-85		
SFDR			87		
SINAD			84		
<b>REFERENCE INPUT</b>					
Reference current	$V_{REF} = V_{DD} = 5.5V$		90	120	$\mu A$
	$V_{REF} = V_{DD} = 3.6V$		60	100	
Reference input range		0		$V_{DD}$	V
Reference input impedance			62		k $\Omega$
<b>LOGIC INPUTS (2)</b>					
Input current				$\pm 1$	$\mu A$
$V_{INL}$ , Input LOW voltage	$V_{DD} = 5V$			0.8	V
	$V_{DD} = 3V$			0.6	
$V_{INH}$ , Input HIGH voltage	$V_{DD} = 5V$	2.4			V
	$V_{DD} = 3V$	2.1			
Pin capacitance				3	pF
<b>POWER REQUIREMENTS</b>					
$V_{DD}$		2.7		5.5	V
$I_{DD}$ (normal mode)	Input code = 32768, no load, does not include reference current				
$V_{DD} = 3.6V$ to $5.5V$	$V_{IH} = V_{DD}$ and $V_{IL} = GND$		340	500	$\mu A$
		$V_{DD} = 2.7V$ to $3.6V$	310	480	
$I_{DD}$ (all power-down modes)	$V_{IH} = V_{DD}$ and $V_{IL} = GND$		0.7	2	$\mu A$
		$V_{DD} = 2.7V$ to $3.6V$	0.4	2	
<b>POWER EFFICIENCY</b>					
$I_{OUT}/I_{DD}$	$I_{LOAD} = 2mA$ , $V_{DD} = 5V$		89		%
<b>TEMPERATURE RANGE</b>					
Specified performance		-40		+105	$^{\circ}C$

(2) Specified by design and characterization; not production tested.

**PIN CONFIGURATION**

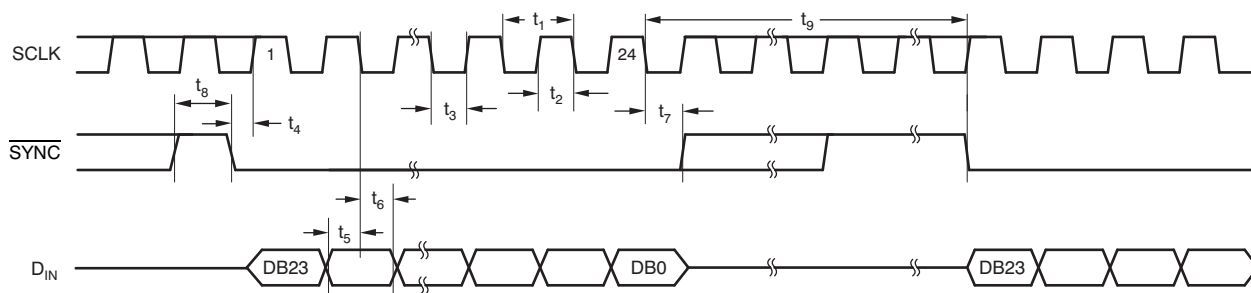
DGK PACKAGE  
MSOP-8  
(Top View)



**PIN DESCRIPTIONS**

PIN	NAME	FUNCTION
1	V <sub>DD</sub>	Power supply input, 2.7V to 5.5V
2	V <sub>REF</sub>	Reference voltage input
3	V <sub>OUTB</sub>	Analog output voltage from DAC B
4	V <sub>OUTA</sub>	Analog output voltage from DAC A
5	$\overline{\text{SYNC}}$	Level triggered $\overline{\text{SYNC}}$ input (active LOW). This is the frame synchronization signal for the input data. When $\overline{\text{SYNC}}$ goes LOW, it enables the input shift register and data is transferred on the falling edges of SCLK. The action specified by the 8-bit control byte and 16-bit data word is executed following the 24th falling SCLK clock edge (unless $\overline{\text{SYNC}}$ is taken HIGH before this edge, in which case the rising edge of $\overline{\text{SYNC}}$ acts as an interrupt and the write sequence is ignored by the DAC8552). Schmitt-Trigger logic input.
6	SCLK	Serial Clock Input. Data can be transferred at rates up to 30MHz at 5V. Schmitt-Trigger logic input.
7	D <sub>IN</sub>	Serial Data Input. Data is clocked into the 24-bit input shift register on the falling edge of the serial clock input. Schmitt-Trigger logic input.
8	GND	Ground reference point for all circuitry on the part.

## SERIAL WRITE OPERATION



## TIMING CHARACTERISTICS<sup>(1)(2)</sup>

$V_{DD} = 2.7V$  to  $5.5V$ , all specifications  $-40^{\circ}C$  to  $+105^{\circ}C$  (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_1^{(3)}$ SCLK cycle time	$V_{DD} = 2.7V$ to $3.6V$	50			ns
	$V_{DD} = 3.6V$ to $5.5V$	33			
$t_2$ SCLK HIGH time	$V_{DD} = 2.7V$ to $3.6V$	13			ns
	$V_{DD} = 3.6V$ to $5.5V$	13			
$t_3$ SCLK LOW time	$V_{DD} = 2.7V$ to $3.6V$	22.5			ns
	$V_{DD} = 3.6V$ to $5.5V$	13			
$t_4$ $\overline{SYNC}$ to SCLK rising edge setup time	$V_{DD} = 2.7V$ to $3.6V$	0			ns
	$V_{DD} = 3.6V$ to $5.5V$	0			
$t_5$ Data setup time	$V_{DD} = 2.7V$ to $3.6V$	5			ns
	$V_{DD} = 3.6V$ to $5.5V$	5			
$t_6$ Data hold time	$V_{DD} = 2.7V$ to $3.6V$	4.5			ns
	$V_{DD} = 3.6V$ to $5.5V$	4.5			
$t_7$ 24th SCLK falling edge to $\overline{SYNC}$ rising edge	$V_{DD} = 2.7V$ to $3.6V$	0			ns
	$V_{DD} = 3.6V$ to $5.5V$	0			
$t_8$ Minimum $\overline{SYNC}$ HIGH time	$V_{DD} = 2.7V$ to $3.6V$	50			ns
	$V_{DD} = 3.6V$ to $5.5V$	33			
$t_9$ 24th SCLK falling edge to $\overline{SYNC}$ falling edge	$V_{DD} = 2.7V$ to $5.5V$	100			ns

(1) All input signals are specified with  $t_R = t_F = 5ns$  (10% to 90% of  $V_{DD}$ ) and timed from a voltage level of  $(V_{IL} + V_{IH})/2$ .

(2) See [Serial Write Operation Timing Diagram](#).

(3) Maximum SCLK frequency is 30MHz at  $V_{DD} = 3.6V$  to  $5.5V$  and 20MHz at  $V_{DD} = 2.7V$  to  $3.6V$ .

**TYPICAL CHARACTERISTICS:  $V_{DD} = 5V$**

At  $T_A = +25^\circ C$ , unless otherwise noted.

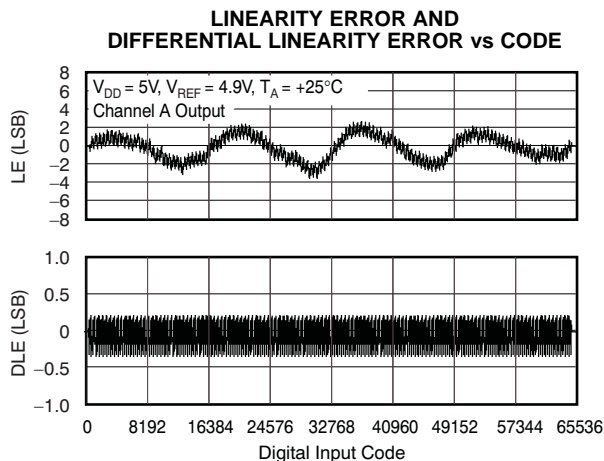


Figure 1.

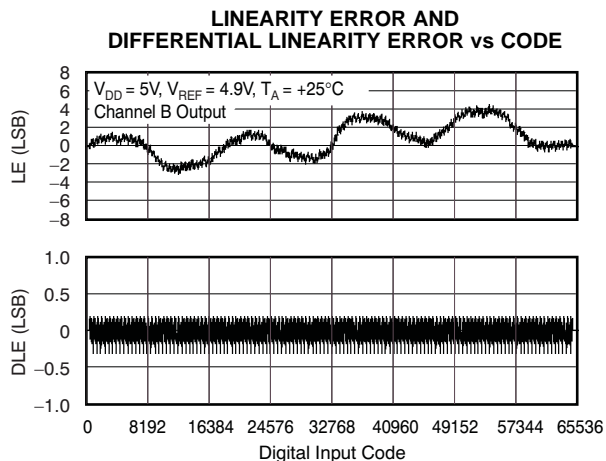


Figure 2.

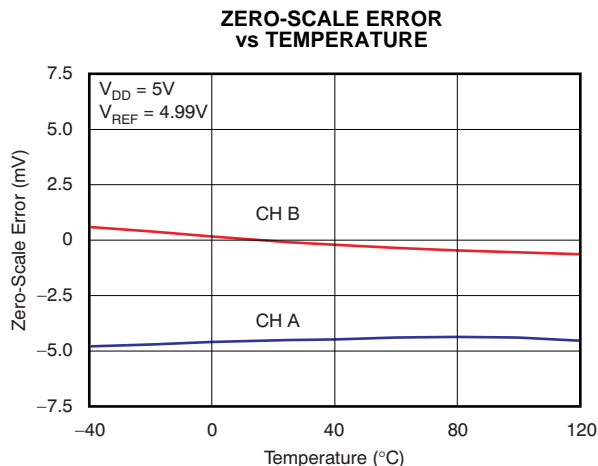


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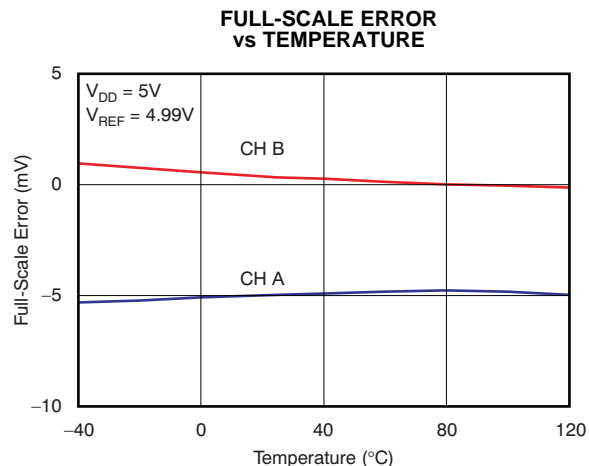


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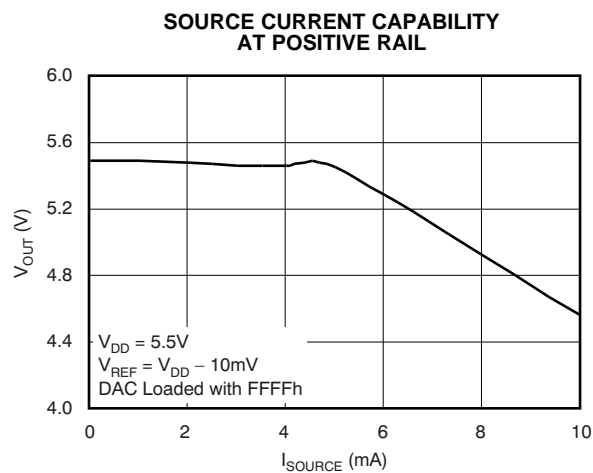


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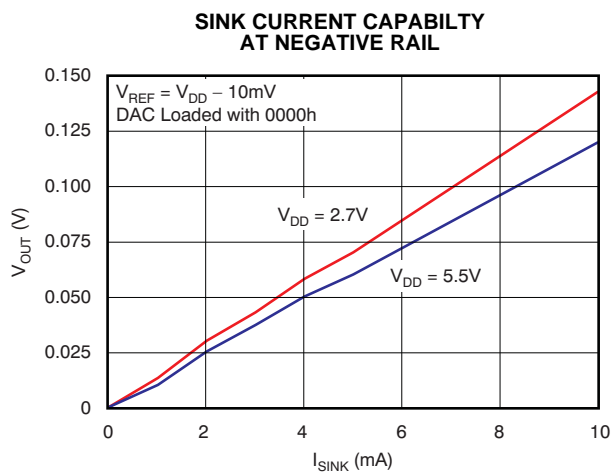


Figure 6.

**TYPICAL CHARACTERISTICS:  $V_{DD} = 5V$  (continued)**

At  $T_A = +25^\circ C$ , unless otherwise noted.

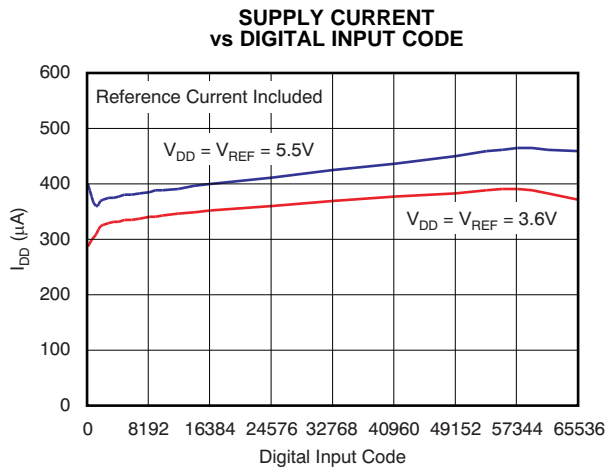


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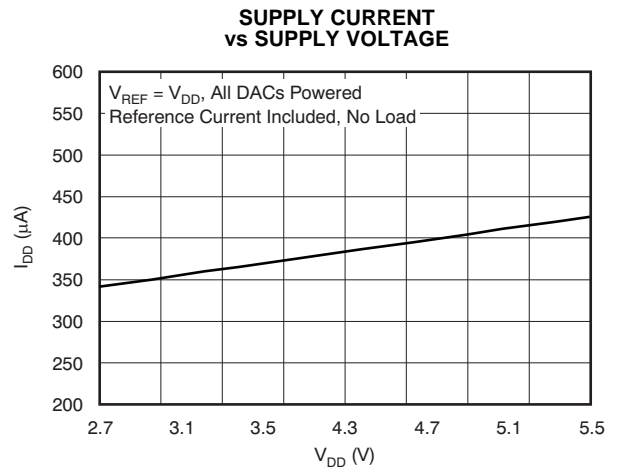


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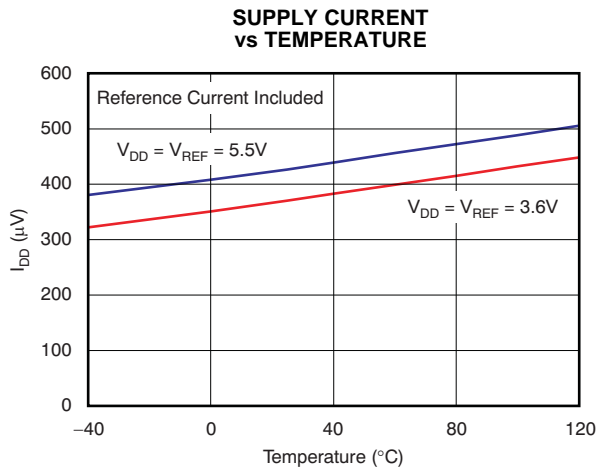


Figure 9.

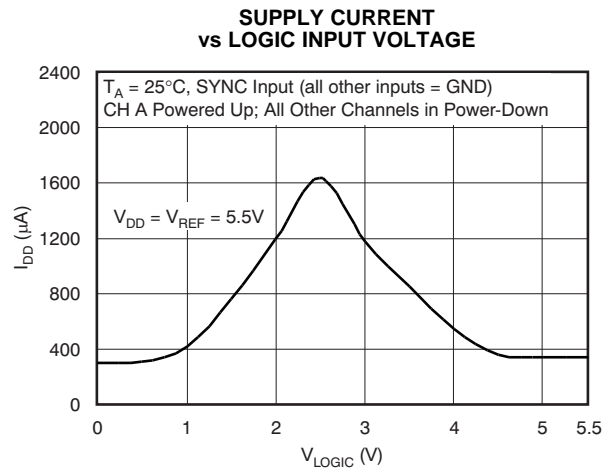


Figure 10.

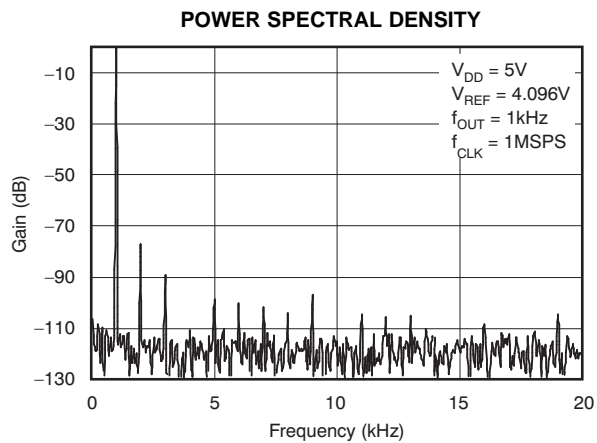


Figure 11.

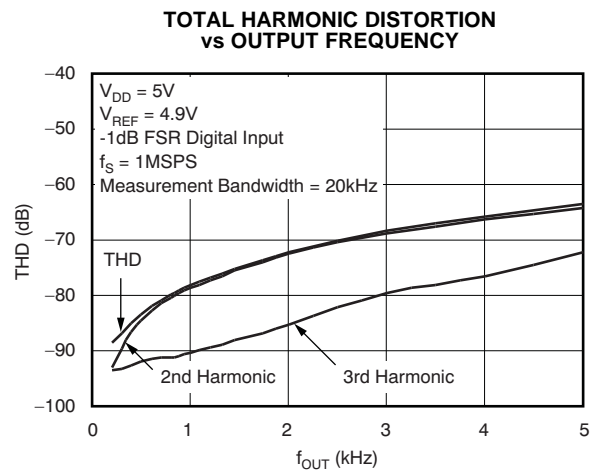


Figure 12.

**TYPICAL CHARACTERISTICS:  $V_{DD} = 5V$  (continued)**

At  $T_A = +25^\circ C$ , unless otherwise noted.

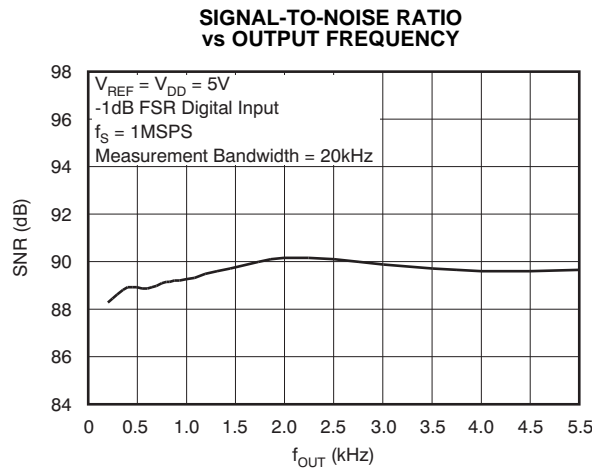


Figure 13.

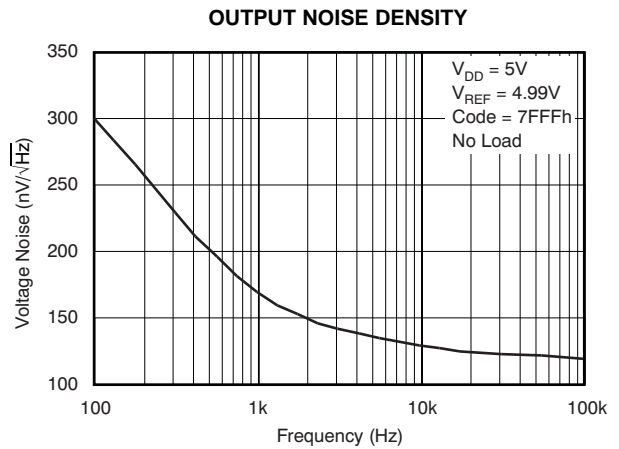


Figure 14.

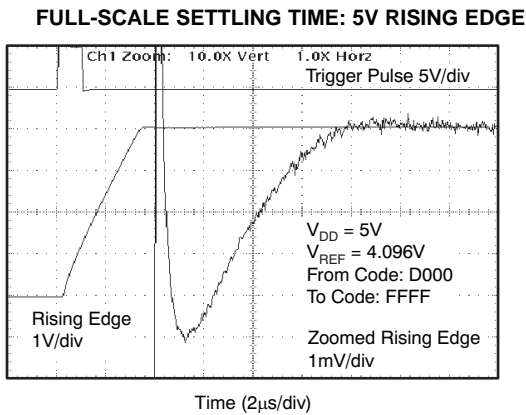


Figure 15.

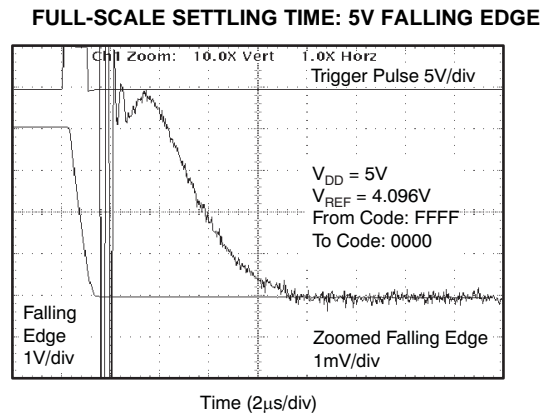


Figure 16.

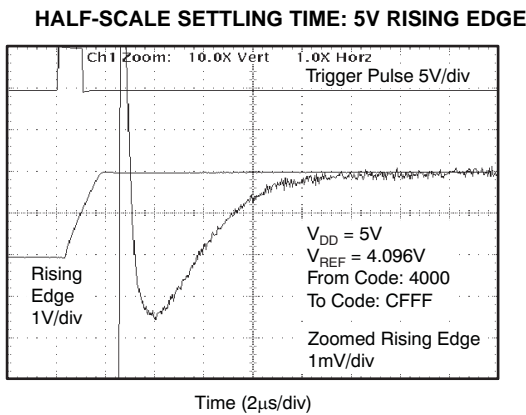


Figure 17.

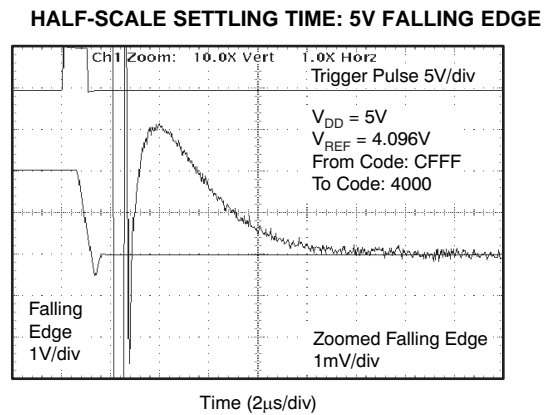
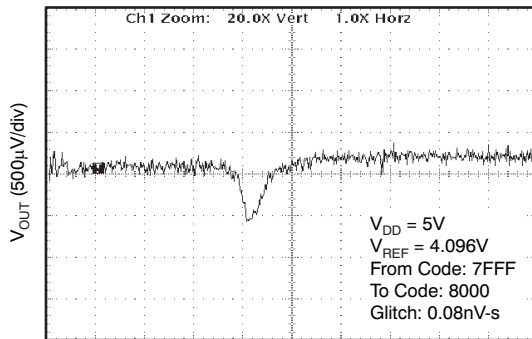


Figure 18.

**TYPICAL CHARACTERISTICS:  $V_{DD} = 5V$  (continued)**

At  $T_A = +25^\circ C$ , unless otherwise noted.

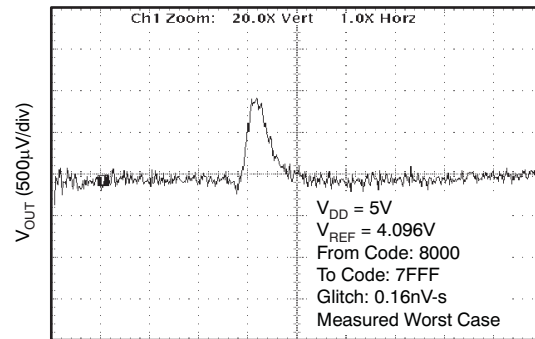
**GLITCH ENERGY: 5V, 1LSB STEP, RISING EDGE**



Time (400ns/div)

**Figure 19.**

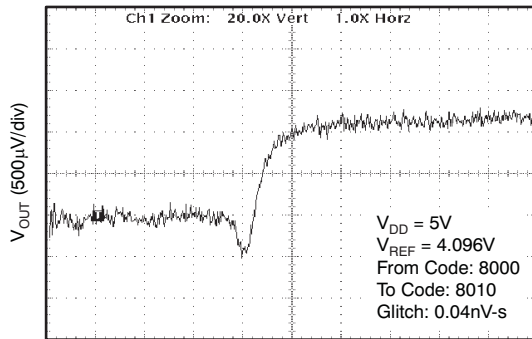
**GLITCH ENERGY: 5V, 1LSB STEP, FALLING EDGE**



Time (400ns/div)

**Figure 20.**

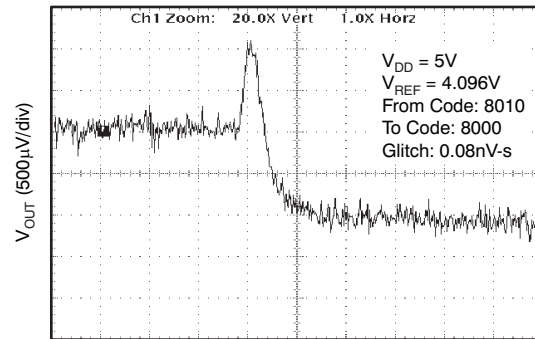
**GLITCH ENERGY: 5V, 16LSB STEP, RISING EDGE**



Time (400ns/div)

**Figure 21.**

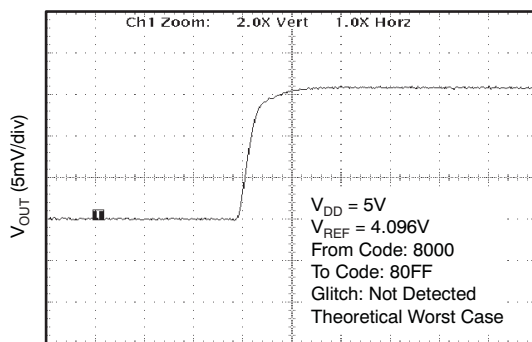
**GLITCH ENERGY: 5V, 16LSB STEP, FALLING EDGE**



Time (400ns/div)

**Figure 22.**

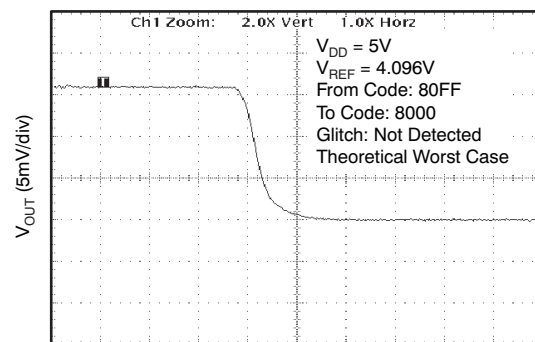
**GLITCH ENERGY: 5V, 256LSB STEP, RISING EDGE**



Time (400ns/div)

**Figure 23.**

**GLITCH ENERGY: 5V, 256LSB STEP, FALLING EDGE**



Time (400ns/div)

**Figure 24.**

**TYPICAL CHARACTERISTICS:  $V_{DD} = 2.7V$**

At  $T_A = +25^\circ C$ , unless otherwise noted.

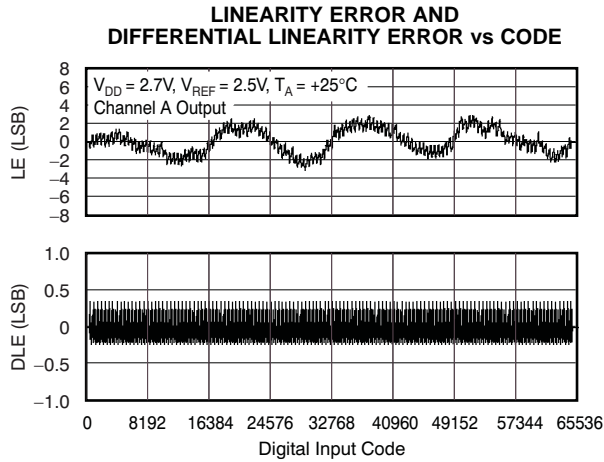


Figure 25.

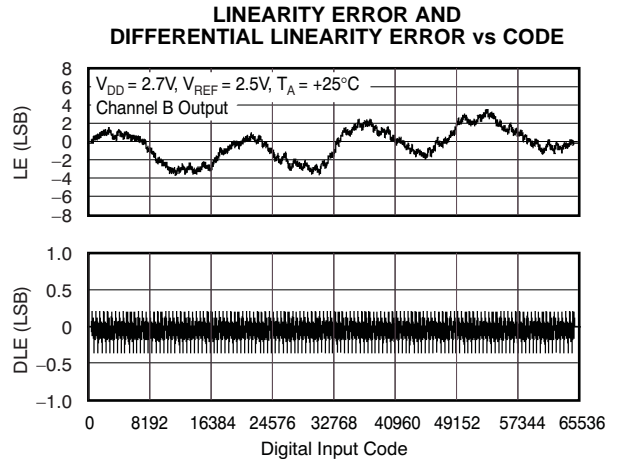


Figure 26.

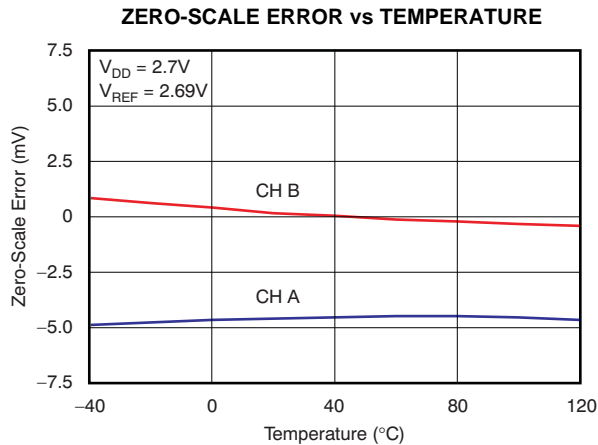


Figure 27.

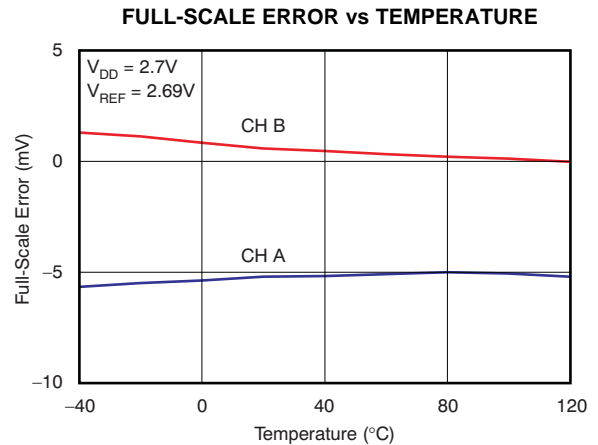


Figure 28.

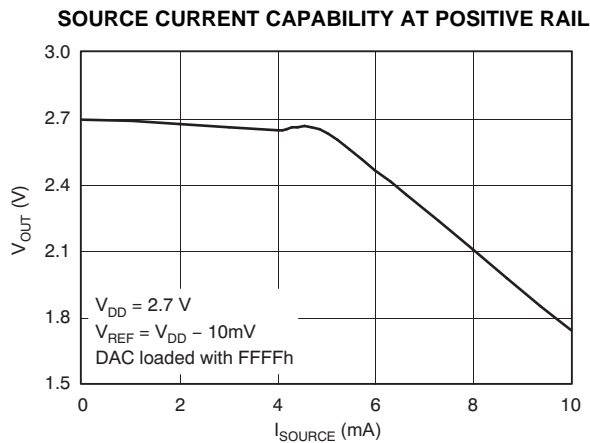


Figure 29.

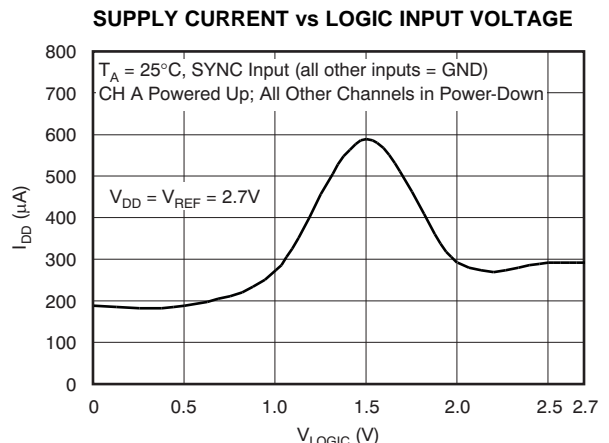
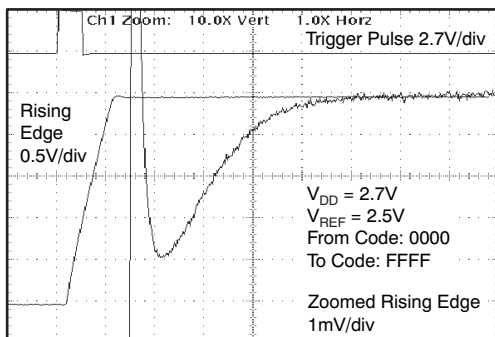


Figure 30.

**TYPICAL CHARACTERISTICS:  $V_{DD} = 2.7V$  (continued)**

At  $T_A = +25^\circ C$ , unless otherwise noted.

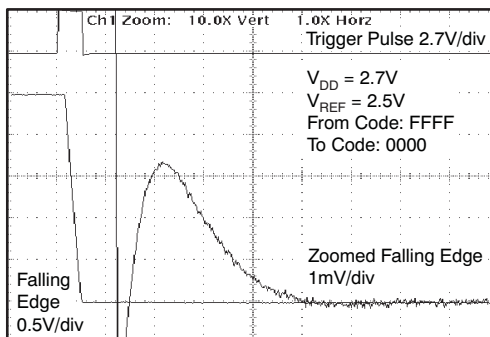
**FULL-SCALE SETTLING TIME: 2.7V RISING EDGE**



Time (2µs/div)

**Figure 31.**

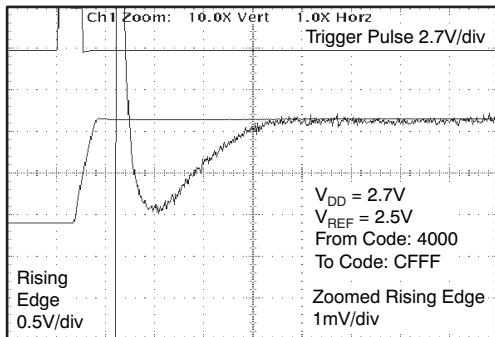
**FULL-SCALE SETTLING TIME: 2.7V FALLING EDGE**



Time (2µs/div)

**Figure 32.**

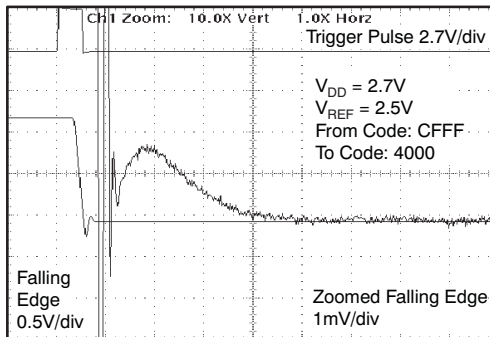
**HALF-SCALE SETTLING TIME: 2.7V RISING EDGE**



Time (2µs/div)

**Figure 33.**

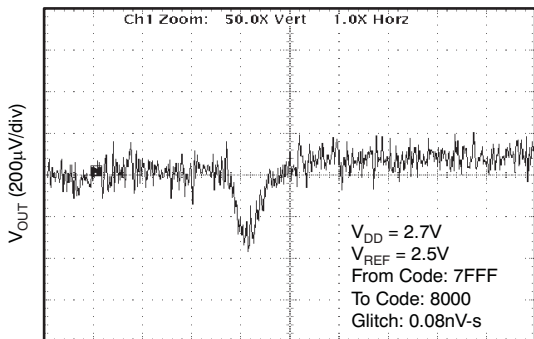
**HALF-SCALE SETTLING TIME: 2.7V FALLING EDGE**



Time (2µs/div)

**Figure 34.**

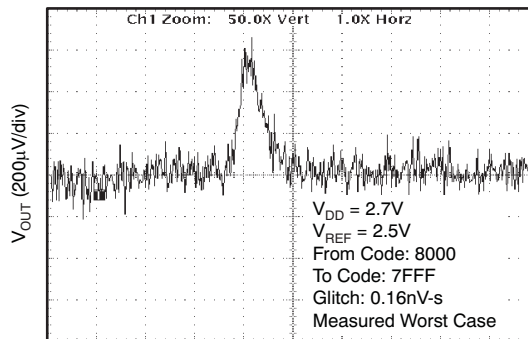
**GLITCH ENERGY: 2.7V, 1LSB STEP, RISING EDGE**



Time (400ns/div)

**Figure 35.**

**GLITCH ENERGY: 2.7V, 1LSB STEP, FALLING EDGE**



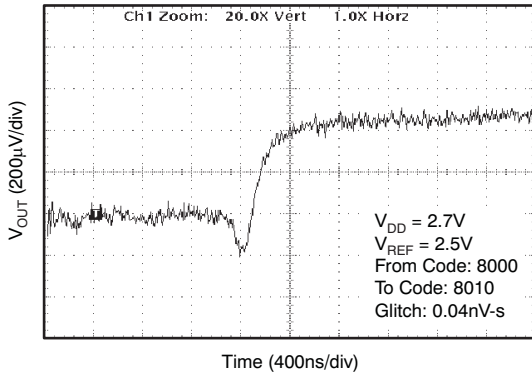
Time (400ns/div)

**Figure 36.**

**TYPICAL CHARACTERISTICS:  $V_{DD} = 2.7V$  (continued)**

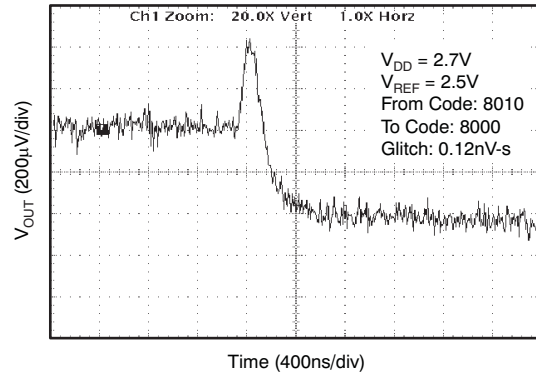
At  $T_A = +25^\circ C$ , unless otherwise noted.

**GLITCH ENERGY: 2.7V, 16LSB STEP, RISING EDGE**



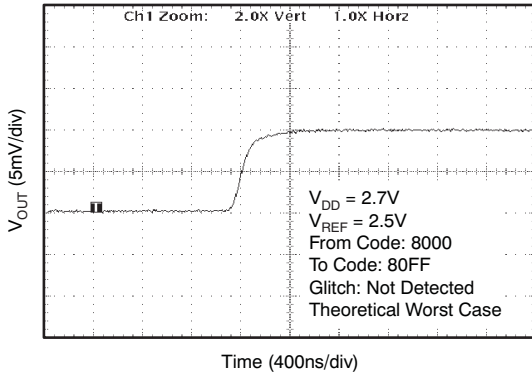
**Figure 37.**

**GLITCH ENERGY: 2.7V, 16LSB STEP, FALLING EDGE**



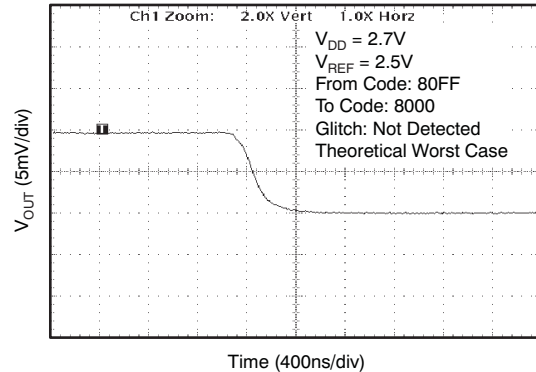
**Figure 38.**

**GLITCH ENERGY: 2.7V, 256LSB STEP, RISING EDGE**



**Figure 39.**

**GLITCH ENERGY: 2.7V, 256LSB STEP, FALLING EDGE**



**Figure 40.**

## THEORY OF OPERATION

### DAC SECTION

The architecture of each channel of the DAC8552 consists of a resistor-string DAC followed by an output buffer amplifier. Figure 41 shows a simplified block diagram of the DAC architecture.

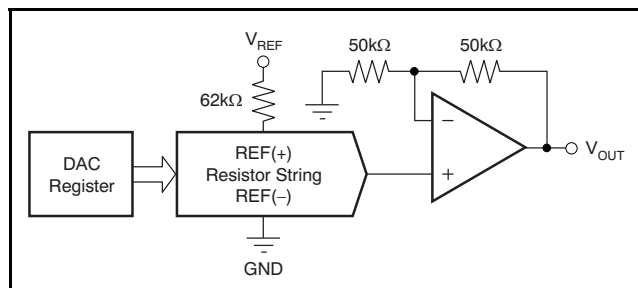


Figure 41. DAC8552 Architecture

The input coding for each device is unipolar straight binary, so the ideal output voltage is given by:

$$V_{OUT\ A,B} = V_{REF} \times \frac{D}{65536} \quad (1)$$

Where:

D = decimal equivalent of the binary code that is loaded to the DAC register; it can range from 0 to 65535.

$V_{OUT\ A,B}$  refers to channel A or B.

### RESISTOR STRING

The resistor string section is shown in Figure 42. It is simply a divide-by-2 resistor followed by a string of resistors, each of value R. The code loaded into the DAC register determines at which node on the string the voltage is tapped off. This voltage is then applied to the output amplifier by closing one of the switches connecting the string to the amplifier.

### OUTPUT AMPLIFIER

Each output buffer amplifier is capable of generating rail-to-rail voltages on its output which approaches an output range of 0V to  $V_{DD}$  (gain and offset errors must be taken into account). Each buffer is capable of driving a load of 2kΩ in parallel with 1000pF to GND. The source and sink capabilities of the output amplifier can be seen in the Typical Characteristics.

### SERIAL INTERFACE

The DAC8552 uses a 3-wire serial interface ( $\overline{SYNC}$ , SCLK, and  $D_{IN}$ ) that is compatible with SPI™, QSP™, and Microwire™ interface standards, as well as most DSPs. See the [Serial Write Operation Timing Diagram](#) for an example of a typical write sequence.

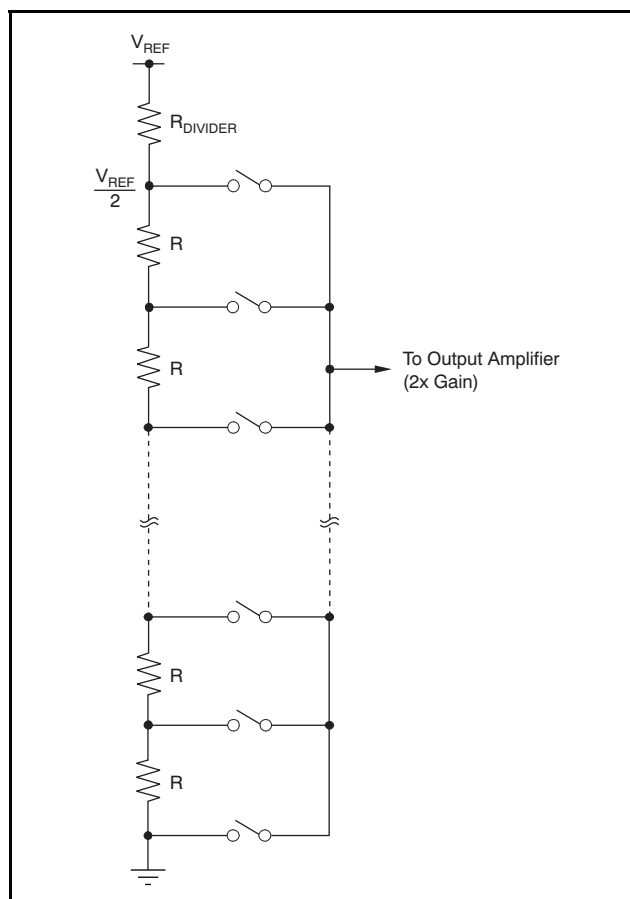


Figure 42. Resistor String

The write sequence begins by bringing the  $\overline{SYNC}$  line LOW. Data from the  $D_{IN}$  line are clocked into the 24-bit shift register on each falling edge of SCLK. The serial clock frequency can be as high as 30MHz, making the DAC8552 compatible with high speed DSPs. On the 24th falling edge of the serial clock, the last data bit is clocked into the shift register and the shift register is locked. Further clocking does not change the shift register data. Once 24 bits are locked into the shift register, the eight MSBs are used as control bits and the 16 LSBs are used as data. After receiving the 24th falling clock edge, the DAC8552 decodes the eight control bits and 16 data bits to perform the required function, without waiting for a  $\overline{SYNC}$  rising edge. A new SPI sequence starts at the next falling edge of  $\overline{SYNC}$ . A rising edge of  $\overline{SYNC}$  before the 24-bit sequence is complete resets the SPI interface; no data transfer occurs.

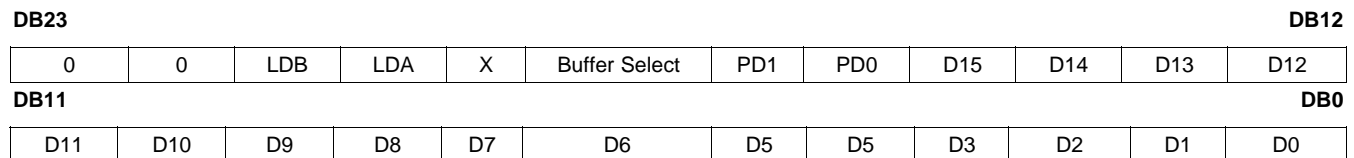
After the 24th falling edge of SCLK is received, the  $\overline{SYNC}$  line may be kept LOW or brought HIGH. In either case, the minimum delay time from the 24th falling SCLK edge to the next falling  $\overline{SYNC}$  edge must be met in order to properly begin the next

cycle. To assure the lowest power consumption of the device, care should be taken that the levels are as close to each rail as possible. (See the Typical Characteristics section for the [Supply Current vs Logic Input Voltage](#) transfer characteristic curve).

### INPUT SHIFT REGISTER

The input shift register of the DAC8552 is 24 bits wide (shown in [Figure 43](#)) and is made up of eight control bits (DB16–DB23) and 16 data bits (DB0–DB15). The first two control bits (DB22 and DB23) are reserved and must be '0' for proper operation. LDA (DB20) and LD B (DB21) control the updating of each analog output with the specified 16-bit data value or power-down command. Bit DB19 is a *don't care* bit that does not affect the operation of the DAC8552, and can be '1' or '0'. The following control bit, Buffer Select (DB18), controls

the destination of the data (or power-down command) between DAC A and DAC B. The final two control bits, PD0 (DB16) and PD1 (DB17), select the power-down mode of one or both of the DAC channels. The four modes are normal mode or any one of three power-down modes. A more complete description of the operational modes of the DAC8552 can be found in the [Power-Down Modes](#) section. The remaining 16 bits of the 24-bit input word make up the data bits. These bits are transferred to the specified Data Buffer or DAC Register, depending on the command issued by the control byte, on the 24th falling edge of SCLK. See [Table 1](#) and [Table 2](#) for more information.



**Figure 43. DAC8552 Data Input Register Format**

**Table 1. Control Matrix**

D23	D22	D21	D20	D19	D18	D17	D16	D15	D14	D13–D0	DESCRIPTION
Reserved	Reserved	Load B	Load A	Don't Care	Buffer Select	PD1	PD0	MSB	MSB-1	MSB-2... LSB	
(Always Write 0)					0 = A, 1 = B						
0	0	0	0	X	#	0	0	Data			WR Buffer # w/Data
0	0	0	0	X	#	See Table 2		X			WR Buffer # w/Power-down Command
0	0	0	1	X	#	0	0	Data			WR Buffer # w/Data and Load DAC A
0	0	0	1	X	0	See Table 2		X			WR Buffer A w/Power-Down Command and LOAD DAC A (DAC A Powered Down)
0	0	0	1	X	1	See Table 2		X			WR Buffer B w/Power-Down Command and LOAD DAC A
0	0	1	0	X	#	0	0	Data			WR Buffer # w/Data and Load DAC B
0	0	1	0	X	0	See Table 2		X			WR Buffer A w/Power-Down Command and LOAD DAC B
0	0	1	0	X	1	See Table 2		X			WR Buffer B w/Power-Down Command and LOAD DAC B (DAC B Powered Down)
0	0	1	1	X	#	0	0	Data			WR Buffer # w/Data and Load DACs A and B
0	0	1	1	X	0	See Table 2		X			WR Buffer A w/Power-Down Command and Load DACs A and B (DAC A Powered Down)
0	0	1	1	X	1	See Table 2		X			WR Buffer B w/Power-Down Command and Load DACs A and B (DAC B Powered Down)

**Table 2. Power-Down Commands**

D17	D16	OUTPUT IMPEDANCE POWER DOWN COMMANDS
PD1	PD0	
0	1	1kΩ
1	0	100kΩ
1	1	High Impedance

### SYNC INTERRUPT

In a normal write sequence, the  $\overline{\text{SYNC}}$  line is kept LOW for at least 24 falling edges of SCLK and the addressed DAC register is updated on the 24th falling edge. However, if  $\overline{\text{SYNC}}$  is brought HIGH before the 24th falling edge, it acts as an interrupt to the write sequence; the shift register is reset and the write sequence is discarded. Neither an update of the data buffer contents, DAC register contents nor a change in the operating mode occurs, as shown in Figure 45.

### POWER-ON RESET

The DAC8552 contains a power-on reset circuit that controls the output voltage during power-up. Upon power-up, the DAC registers are filled with zeros and the output voltages are set to zero-scale; they remain that way until a valid write sequence and load command are made to the respective DAC channel. The power-on reset is useful in applications where it is important to know the state of the output of each DAC output while the device is in the process of powering up.

No device pin should be brought high before power is applied to the device.

### POWER-DOWN MODES

The DAC8552 uses four modes of operation. These modes are accessed by setting two bits (PD1 and PD0) in the control register to one or both DACs. Table 3 shows how the state of the bits correspond to the register and perform a mode of operation on each channel of the device. (Each DAC channel can be powered down simultaneously or independently of each other. Power-down occurs after proper data is written into PD0 and PD1 and a Load command occurs.) See the Operation Examples section for additional information.

When both bits are set to '0', the device works normally with a typical power consumption of 450µA at 5V. For the three power-down modes, however, the supply current falls to 700nA at 5V (400nA at

3V). Not only does the supply current fall, but the output stage is also internally switched from the output of the amplifier to a resistor network of known values. This configuration has the advantage that the output impedance of the device is known while it is in power-down mode. There are three different options for power-down: The output is connected internally to GND through a 1kΩ resistor, a 100kΩ resistor, or it is left open-circuited (High-Impedance). The output stage is illustrated in Figure 44.

Table 3. Operating Modes

PD1 (DB17)	PD0 (DB16)	OPERATING MODE
0	0	Normal Operation
—	—	Power-down modes
0	1	Output typically 1kΩ to GND
1	0	Output typically 100kΩ to GND
1	1	High impedance

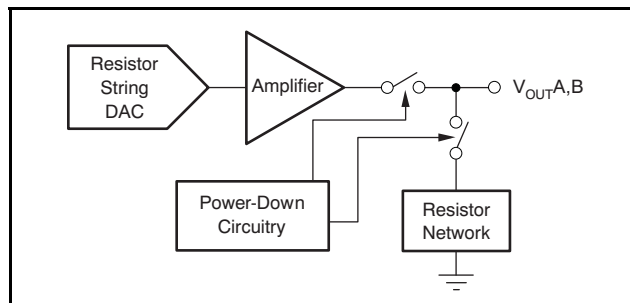


Figure 44. Output Stage During Power-Down (High Impedance)

All analog circuitry is shut down when the power-down mode is activated. Each DAC will exit power-down when PD0 and PD1 are set to '0', new data is written to the Data Buffer, and the DAC channel receives a Load command. The time to exit power-down is typically 2.5µs for  $V_{DD} = 5V$  and 5µs for  $V_{DD} = 3V$  (see the Typical Characteristics).

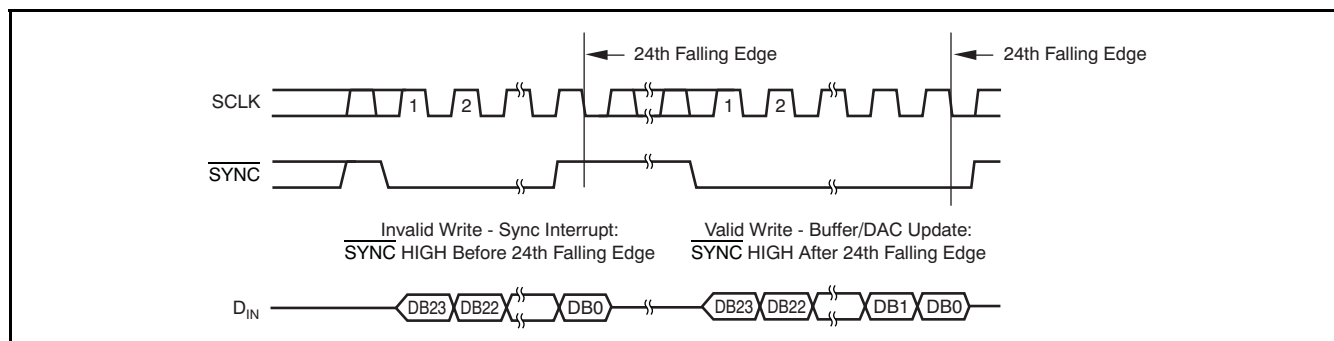


Figure 45. Interrupt and Valid  $\overline{\text{SYNC}}$  Timing

**OPERATION EXAMPLES**

**Example 1: Write to Data Buffer A Through Buffer B; Load DAC A Through DAC B Simultaneously**

- 1st — Write to Data Buffer A:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	0	0	X	0	0	0	D15	—	D1	D0

- 2nd — Write to Data Buffer B and Load DAC A and DAC B simultaneously:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	1	1	X	1	0	0	D15	—	D1	D0

The DAC A and DAC B analog outputs simultaneously settle to the specified values upon completion of the 2nd write sequence. (The *Load* command moves the digital data from the data buffer to the DAC register at which time the conversion takes place and the analog output is updated. *Completion* occurs on the 24th falling SCLK edge after SYNC LOW.)

**Example 2: Load New Data to DAC A and DAC B Sequentially**

- 1st — Write to Data Buffer A and Load DAC A: DAC A output settles to specified value upon completion:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	0	1	X	0	0	0	D15	—	D1	D0

- 2nd — Write to Data Buffer B and Load DAC B: DAC B output settles to specified value upon completion:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	1	0	X	1	0	0	D15	—	D1	D0

After completion of the 1st write cycle, the DAC A analog output settles to the voltage specified; upon completion of write cycle 2, the DAC B analog output settles.

**Example 3: Power-Down DAC A to 1kΩ and Power-Down DAC B to 100kΩ Simultaneously**

- 1st — Write power-down command to Data Buffer A:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	0	0	X	0	0	1	Don't Care			

- 2nd — Write power-down command to Data Buffer B and Load DAC A and DAC B simultaneously:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	1	1	X	1	1	0	Don't Care			

The DAC A and DAC B analog outputs simultaneously power-down to each respective specified mode upon completion of the 2nd write sequence.

**Example 4: Power-Down DAC A and DAC B to High-Impedance Sequentially:**

- 1st — Write power-down command to Data Buffer A and Load DAC A: DAC A output = Hi-Z:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	0	1	X	0	1	1	Don't Care			

- 2nd — Write power-down command to Data Buffer B and Load DAC B: DAC B output = Hi-Z:

Reserved	Reserved	LDB	LDA	DC	Buffer Select	PD1	PD0	DB15	—	DB1	DB0
0	0	1	0	X	1	1	1	Don't Care			

The DAC A and DAC B analog outputs sequentially power-down to high-impedance upon completion of the 1st and 2nd write sequences, respectively.

## MICROPROCESSOR INTERFACING

### DAC8552 to 8051 INTERFACE

Figure 46 shows a serial interface between the DAC8552 and a typical 8051-type microcontroller. The setup for the interface is as follows: TXD of the 8051 drives SCLK of the DAC8552, while RXD drives the serial data line of the device. The  $\overline{\text{SYNC}}$  signal is derived from a bit-programmable pin on the port of the 8051. In this case, port line P3.3 is used. When data are to be transmitted to the DAC8552, P3.3 is taken LOW. The 8051 transmits data in 8-bit bytes; thus, only eight falling clock edges occur in the transmit cycle. To load data to the DAC, P3.3 is left LOW after the first eight bits are transmitted, then a second and third write cycle are initiated to transmit the remaining data. P3.3 is taken HIGH following the completion of the third write cycle. The 8051 outputs the serial data in a format that presents the LSB first, while the DAC8552 requires its data with the MSB as the first bit received. The 8051 transmit routine must therefore take this into account, and *mirror* the data as needed.

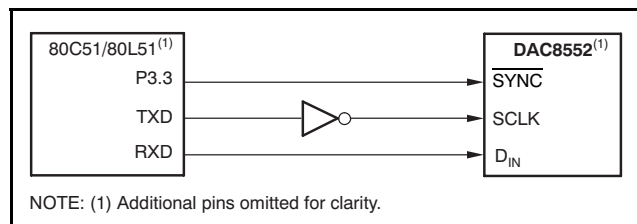


Figure 46. DAC8552 to 80C51/80L51 Interface

### DAC8552 to Microwire INTERFACE

Figure 47 shows an interface between the DAC8552 and any Microwire-compatible device. Serial data are shifted out on the falling edge of the serial clock and clocked into the DAC8552 on the rising edge of the SK signal.

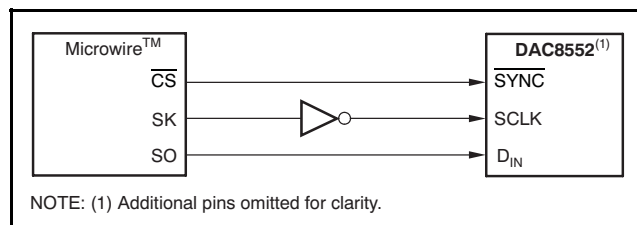


Figure 47. DAC8552 to Microwire Interface

### DAC8552 to 68HC11 INTERFACE

Figure 48 shows a serial interface between the DAC8552 and the 68HC11 microcontroller. SCK of the 68HC11 drives the SCLK of the DAC8552, while the MOSI output drives the serial data line of the DAC. The  $\overline{\text{SYNC}}$  signal is derived from a port line (PC7), similar to the 8051 diagram.

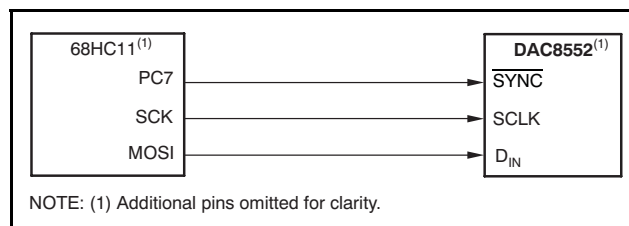


Figure 48. DAC8552 to 68HC11 Interface

The 68HC11 should be configured so that its CPOL bit is '0' and its CPHA bit is '1'. This configuration causes data appearing on the MOSI output to be valid on the falling edge of SCK. When data are being transmitted to the DAC, the  $\overline{\text{SYNC}}$  line is held LOW (PC7). Serial data from the 68HC11 are transmitted in 8-bit bytes with only eight falling clock edges occurring in the transmit cycle. (Data are transmitted MSB first.) In order to load data to the DAC8552, PC7 is left LOW after the first eight bits are transferred, then a second and third serial write operation are performed to the DAC. PC7 is taken HIGH at the end of this procedure.

### DAC8552 to TMS320 DSP INTERFACE

Figure 49 shows the connections between the DAC8552 and a TMS320 digital signal processor. By decoding the FSX signal, multiple DAC8552s can be connected to a single serial port of the DSP.

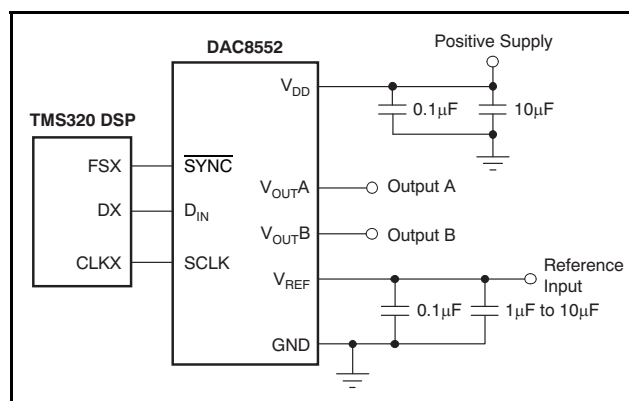


Figure 49. DAC8552 to TMS320 DSP

## APPLICATION INFORMATION

### CURRENT CONSUMPTION

The DAC8552 typically consumes 170 $\mu$ A at  $V_{DD} = 5$  V and 155 $\mu$ A at  $V_{DD} = 2.7$  V for each active channel, excluding reference current consumption. Additional current consumption can occur at the digital inputs if  $V_{IH} \ll V_{DD}$ . For most efficient power operation, CMOS logic levels are recommended at the digital input to the DAC.

In power-down mode, typical current consumption is 700nA. A delay time of 10ms to 20ms after a power-down command is issued to the DAC is typically sufficient for the power-down current to drop below 10 $\mu$ A.

### DRIVING RESISTIVE AND CAPACITIVE LOADS

The DAC8552 output stage is capable of driving loads of up to 1000pF while remaining stable. Within the offset and gain error margins, the DAC8552 can operate rail-to-rail when driving a capacitive load. Resistive loads of 2k $\Omega$  can be driven by the DAC8552 while achieving good load regulation. When the outputs of the DAC are driven to the positive rail under resistive loading, the PMOS transistor of each Class-AB output stage can enter into the linear region. When this scenario occurs, the added IR voltage drop deteriorates the linearity performance of the DAC. This deterioration only occurs within approximately the top 100mV of the DACs output voltage characteristic. Under resistive loading conditions, good linearity is preserved as long as the output voltage is at least 100mV below the  $V_{DD}$  voltage.

### CROSSTALK AND AC PERFORMANCE

The DAC8552 architecture uses separate resistor strings for each DAC channel in order to achieve ultra-low crosstalk performance. dc crosstalk seen at one channel during a full-scale change on the neighboring channel is typically less than 0.5 LSBs. The ac crosstalk measured (for a full-scale, 1kHz sine wave output generated at one channel, and measured at the remaining output channel) is typically under –100dB.

In addition, the DAC8552 can achieve typical ac performance of 96dB signal-to-noise ratio (SNR) and –85dB total harmonic distortion (THD), making the DAC8552 a solid choice for applications requiring high SNR at output frequencies at or below 10kHz.

### OUTPUT VOLTAGE STABILITY

The DAC8552 exhibits excellent temperature stability of 5ppm/ $^{\circ}$ C typical output voltage drift over the specified temperature range of the device. This stability enables the output voltage of each channel to stay within a  $\pm 25\mu$ V window for a  $\pm 1^{\circ}$ C ambient temperature change.

Good power-supply rejection ratio (PSRR) performance reduces supply noise present on  $V_{DD}$  from appearing at the outputs. Combined with good dc noise performance and true 16-bit differential linearity, the DAC8552 becomes an ideal choice for closed-loop control applications.

### SETTLING TIME AND OUTPUT GLITCH PERFORMANCE

The DAC8552 settles to  $\pm 0.003\%$  of its full-scale range within 10 $\mu$ s, driving a 200pF, 2k $\Omega$  load. For good settling performance, the outputs should not approach the top and bottom rails. Small signal settling time is under 1 $\mu$ s, enabling data update rates exceeding 1MSPS for small code changes.

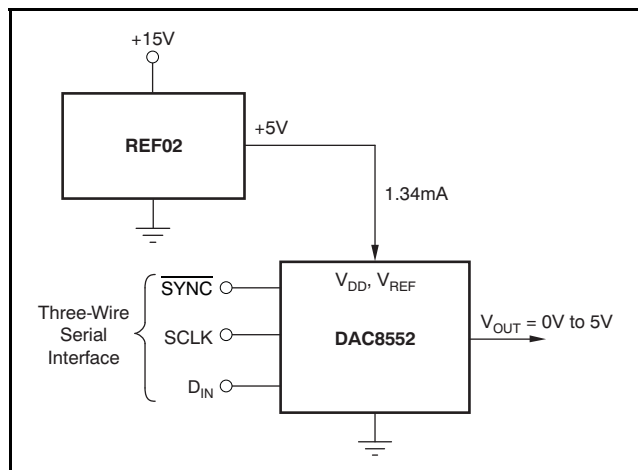
Many applications are sensitive to undesired transient signals such as glitch. The DAC8552 has a proprietary, ultra-low glitch architecture addressing such applications. Code-to-code glitches rarely exceed 1mV and they last under 0.3 $\mu$ s. Typical glitch energy is an outstanding 0.15nV-s. Theoretical worst-case glitch should occur during a 256LSB step, but it is so low, it cannot be detected.

### DIFFERENTIAL AND INTEGRAL NONLINEARITY

The DAC8552 uses precision, thin-film resistors to achieve monotonicity and good linearity. Typical linearity error is  $\pm 4$ LSBs, with a  $\pm 0.3$ mV error for a 5V range. Differential linearity is typically  $\pm 0.35$ LSBs, with a  $\pm 27\mu$ V error for a consecutive code change.

## USING REF02 AS A POWER SUPPLY FOR DAC8552

Due to the extremely low supply current required by the DAC8552, a possible configuration is to use a REF02 +5V precision voltage reference to supply the required voltage to the DAC8552 supply input as well as the reference input, as shown in Figure 50.



**Figure 50. REF02 as a Power Supply to the DAC8552**

This configuration is especially useful if the power supply is quite noisy or if the system supply voltages are at some value other than 5V. The REF02 will output a steady supply voltage for the DAC8552. If the REF02 is used, the current it needs to supply to

the DAC8552 is 340μA typical and 500μA max for  $V_{DD} = 5V$ . When a DAC output is loaded, the REF02 also needs to supply the current to the load. The typical current required (with a 5kΩ load on a given DAC output) is:

$$340\mu\text{A} + (5V/5k\Omega) = 1.34\text{mA}$$

## BIPOLAR OPERATION USING THE DAC8552

The DAC8552 has been designed for single-supply operation but a bipolar output range is also possible using the circuit in Figure 51. The circuit shown here gives an output voltage range of  $\pm V_{REF}$ . Rail-to-rail operation at the amplifier output is achievable using an amplifier such as the OPA703, as shown in Figure 51.

The output voltage for any input code can be calculated as follows:

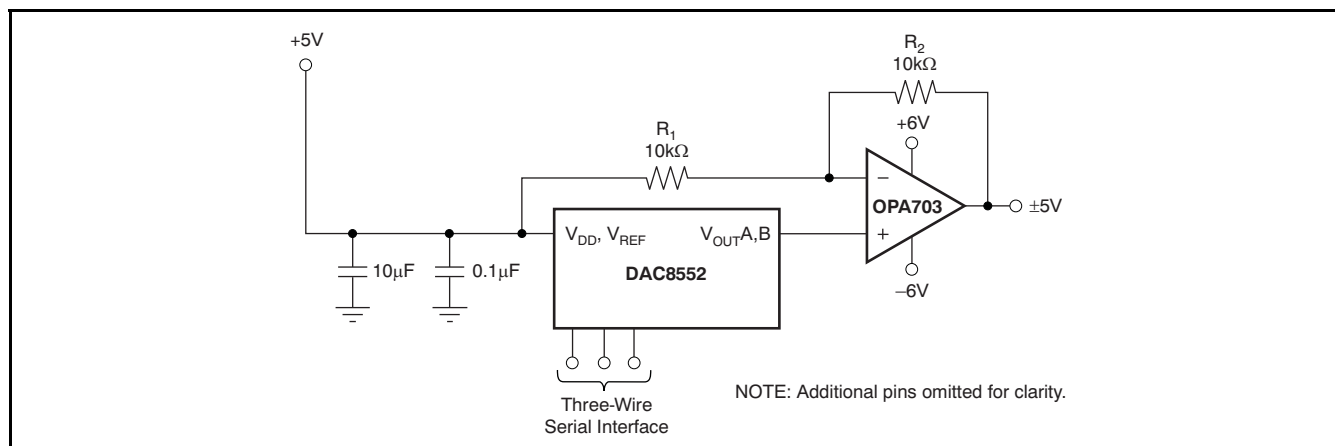
$$V_{OUT\ A, B} = \left[ V_{REF} \times \left( \frac{D}{65536} \right) \times \left( \frac{R_1 + R_2}{R_1} \right) - V_{REF} \times \left( \frac{R_2}{R_1} \right) \right] \quad (2)$$

where D represents the input code in decimal (0–65535).

With  $V_{REF} = 5V$ ,  $R_1 = R_2 = 10k\Omega$ .

$$V_{OUT\ A, B} = \left( \frac{10 \times D}{65536} \right) - 5V \quad (3)$$

Using this example, an output voltage range of  $\pm 5V$  with 0000h corresponding to a –5V output and FFFFh corresponding to a 5V output can be achieved. Similarly, using  $V_{REF} = 2.5V$ , a  $\pm 2.5V$  output voltage range can be achieved.



**Figure 51. Bipolar Operation with the DAC8552**

## LAYOUT

A precision analog component requires careful layout, adequate bypassing, and clean, well-regulated power supplies.

The DAC8552 offers single-supply operation, and it will often be used in close proximity with digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to keep digital noise from appearing at the output.

Due to the single ground pin of the DAC8552, all return currents, including digital and analog return currents for the DAC, must flow through a single point. Ideally, GND would be connected directly to an analog ground plane. This plane would be separate from the ground connection for the digital components until they are connected at the power entry point of the system.

The power applied to  $V_{DD}$  should be well-regulated and low-noise. Switching power supplies and dc/dc converters will often have high-frequency glitches or spikes riding on the output voltage. In addition, digital components can create similar high-frequency spikes. This noise can easily couple into the DAC output voltage through various paths between the power connections and analog output.

As with the GND connection,  $V_{DD}$  should be connected to a positive power-supply plane or trace that is separate from the connection for digital logic until they are connected at the power entry point. In addition, a 1 $\mu$ F to 10 $\mu$ F capacitor in parallel with a 0.1 $\mu$ F bypass capacitor is strongly recommended. In some situations, additional bypassing may be required, such as a 100 $\mu$ F electrolytic capacitor or even a *Pi* filter made up of inductors and capacitors—all designed to essentially low-pass filter the supply, removing the high-frequency noise.

## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">DAC8552IDGKR</a>	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	Call TI   Nipdauag	Level-2-260C-1 YEAR	-40 to 105	D82
DAC8552IDGKR.A	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 105	D82
<a href="#">DAC8552IDGKT</a>	Active	Production	VSSOP (DGK)   8	250   SMALL T&R	Yes	Call TI   Nipdauag	Level-1-260C-UNLIM	-40 to 105	D82
DAC8552IDGKT.A	Active	Production	VSSOP (DGK)   8	250   SMALL T&R	Yes	Call TI	Level-1-260C-UNLIM	-40 to 105	D82
DAC8552IDGKTG4	Active	Production	VSSOP (DGK)   8	250   SMALL T&R	Yes	Call TI	Level-1-260C-UNLIM	-40 to 105	D82

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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# DGK0008A



# PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



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**NOTES:**

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

# EXAMPLE BOARD LAYOUT

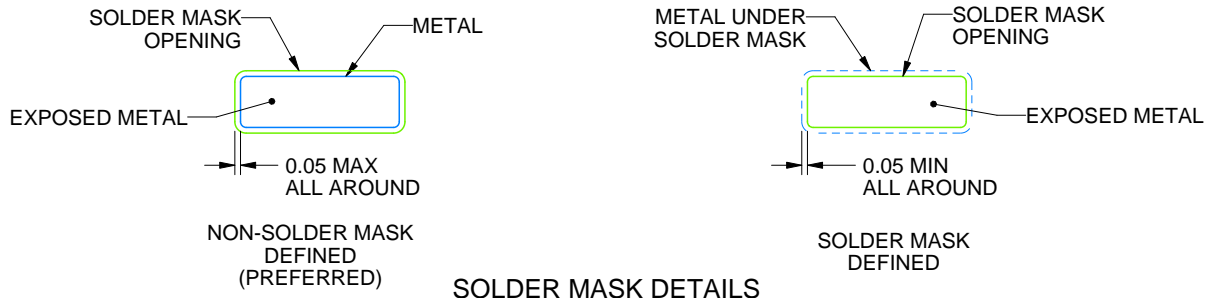
DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 15X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

DGK0008A

<sup>TM</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
SCALE: 15X

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NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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